Notice of References Cited

Application/Control No.	pplicant(s)/Pater	nt Under	
09/679,212	Reexamination GUPTA, DEEPAR	Reexamination GUPTA, DEEPAK	
Examiner	Art Unit		
Quang N. Nguyen	2141	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,108,709	08-2000	Shinomura et al.	709/239
	В	US-6,163,809	12-2000	Buckley, David	709/204
	С	US-6,438,583	08-2002	McDowell et al.	709/206
	D	US-5,473,602	12-1995	McKenna et al.	370/256
	Ε	US-5,682,460	10-1997	Hyziak et al.	709/217
	F	US-5,878,230	03-1999	Weber et al.	709/238
	G	US-5,937,161	08-1999	Mulligan et al.	709/238
	Н	US-6,035,104	03-2000	Zahariev, Manuel	709/203
	1	US-6,282,574	08-2001	Voit, Eric A.	709/230
	J	US-6,480,484	11-2002	Morton, Michael D.	709/218
	К	US-6,532,489	03-2003	Merchant, Sailesh Mansinh	709/206
	L	US-6,618,747	09-2003	Flynn et al.	709/206
П	М	US-6,643,687	11-2003	Dickie et al.	709/238

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.